

Absolute Maximum Ratings

Symbol	Conditions ¹⁾	Values			Units
		... 101 D	... 121 D	... 122 D	
V _{CES}		1000	1200		V
V _{GCR}	R _{GE} = 20 kΩ	1000	1200		V
I _c	T _{case} = 25/80 °C	200/150			A
I _{CM}	T _{case} = 25/80 °C	400/300			A
V _{GES}		± 20			V
P _{tot}	per IGBT, T _{case} = 25 °C	1250			W
T _j , T _{stg}		- 55 ... +150			°C
V _{isol}	AC, 1 min	2 500			V
humidity	DIN 40 040	Class F			
climate	DIN IEC 68 T.1	55/150/56			
Inverse Diode					
I _F = - I _c		200			A
I _{FM} = - I _{CM}		400			A

Characteristics

Symbol	Conditions ¹⁾	min.	typ.	max.	Units
		V _{G(BR)CES}	≥ V _{CES}	-	
V _{G(E)th}	V _{GE} = V _{CE} , I _c = 10 mA	4,5	5,5	6,5	V
I _{CES}	V _{GE} = 0 T _j = 25 °C	-	-	2	mA
I _{GES}	V _{CE} = V _{CES} T _j = 125 °C	-	-	10	mA
V _{CESat}	V _{GE} = 20 V, V _{CE} = 0	-	-	100	nA
V _{CESat}	V _{GE} = 15 V T _j = 25 °C	-	3,5	4	V
	I _c = 200 A T _j = 150 °C	-	4	4,8	V
g _f	V _{CE} = 20 V, I _c = 200 A	66	96	-	S
C _{CHC}	per IGBT	-	-	200	pF
C _{ies}	V _{GE} = 0	-	22	-	nF
C _{oes}	V _{CE} = 25 V	-	1700	-	pF
C _{res}	f = 1 MHz	-	700	-	pF
L _{CE}		-	-	80	nH
t _{d(on)}	V _{CC} = 600 V	-	190 ³⁾	-	ns
t _r	V _{GE} = 15 V	-	450 ³⁾	-	ns
t _{d(off)}	I _c = 200 A	-	-1100 ^{3)/1100 ⁴⁾}	-	ns
t _r	R _{Gon} = R _{Goff} = 3,3 Ω	-	-450 ^{3)/100 ⁴⁾}	-	ns
W _{off12} ⁵⁾	T _j = 125 °C	-	18 ⁴⁾	-	mWs
W _{off23} ⁵⁾		-	9 ⁴⁾	-	mWs
Inverse Diode ... 101 D, ... 102 D					
V _F = V _{EC}	I _F = 200 A, V _{GE} = 0; (T _j) = 125 °C	-	2,0 (1,8)	2,8	V
t _{rr}	T _j = 25 °C ²⁾	-	-	-	ns
	T _j = 125 °C ²⁾	-	350	-	ns
Q _{rr}	T _j = 25/125 °C ²⁾	-	6/27	-	μC
f _s	f _s = t _r / (t _{rr} - t _r)	-	1 ²⁾	-	

Inverse Diode ... 121 D, ... 122 D

V _F = V _{EC}	I _F = 200 A, V _{GE} = 0; (T _j) = 125 °C	-	2,8 (2,1)	3,3	V
t _{rr}	T _j = 25 °C ²⁾	-	-	-	ns
	T _j = 125 °C ²⁾	-	400	-	ns
Q _{rr}	T _j = 25/125 °C ²⁾	-	7,5/30	-	μC
f _s	f _s = t _r / (t _{rr} - t _r)	-	1 ²⁾	-	

Thermal Characteristics

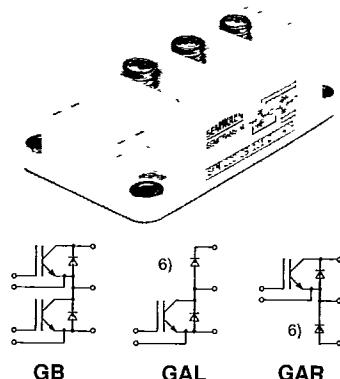
R _{thjc}	per IGBT	-	-	0,1	°C/W
R _{thjc}	per diode	-	-	0,38	°C/W
R _{thch}	per module	-	-	0,038	°C/W

Cases and mechanical data see page B 6 – 142

**SEMITRANS® M
IGBT Modules**

SKM 200 GB 101 D, 102 D
 SKM 200 GAL 101 D, 102 D ⁶⁾
 SKM 200 GAR 101 D ⁶⁾
 SKM 200 GB 121 D, 122 D
 SKM 200 GAL 121 D, 122 D ⁶⁾
 SKM 200 GAR 121 D, 122 D ⁶⁾

T-39-31

**Features**

- MOS input (voltage controlled)
- N channel
- Low saturation voltage
- Very low tail current
- Low temperature sensitivity
- High short circuit capability
- No latch-up
- Fast inverse diodes
- Isolated copper baseplate
- Large clearances and creepage distances
- UL recognized, file no. E 63 532

Typical Applications

→ page B 6 – 127

¹⁾ T_{case} = 25 °C, unless otherwise specified²⁾ I_F = - I_c, V_R = 600 V,
- dI/dt = 800 A/μs, V_{GE} = 0³⁾ resistive load⁴⁾ inductive load⁵⁾ see fig. 21; R_{Goff} = 3,4 Ω⁶⁾ The free-wheeling diodes of the GAL and GAR types have the data of the inverse diodes of SKM 300 ...

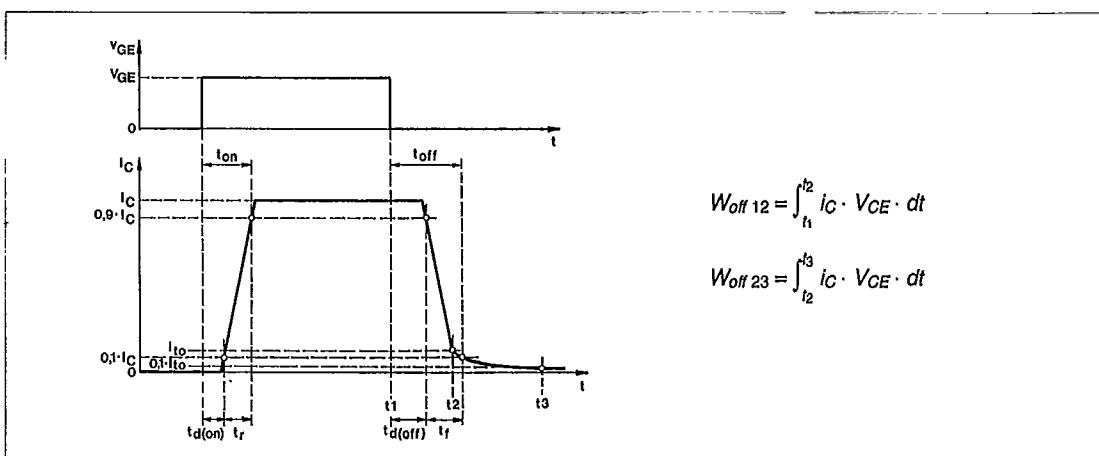


Fig. 21 Switching times and turn-off energies

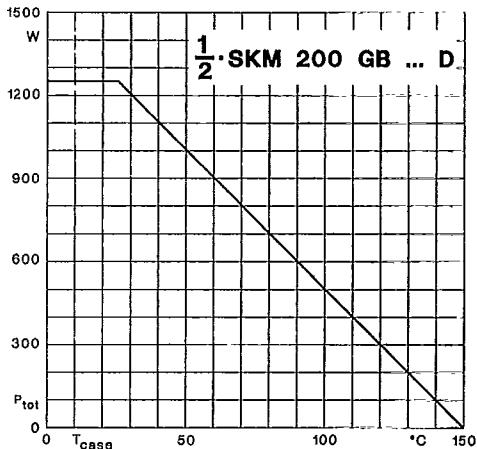


Fig. 22 Rated power dissipation vs. temperature

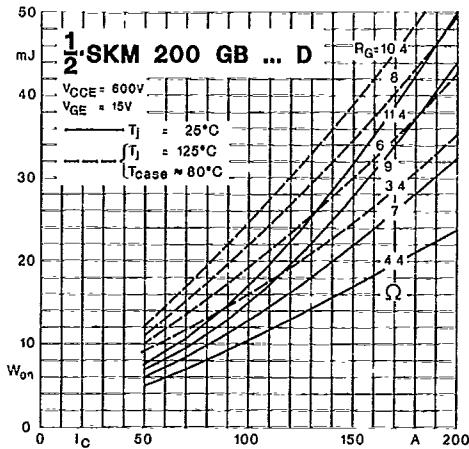


Fig. 23 Turn-on energy dissipation per pulse

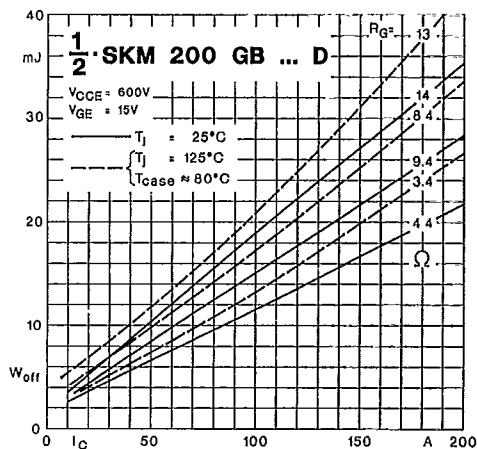


Fig. 24 Turn-off energy dissipation per pulse

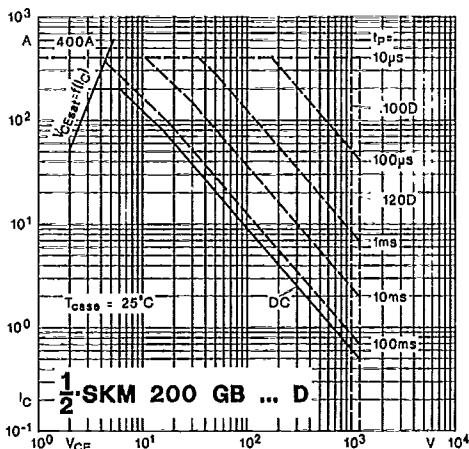


Fig. 25 Maximum safe operating area

SEMIKRON INC

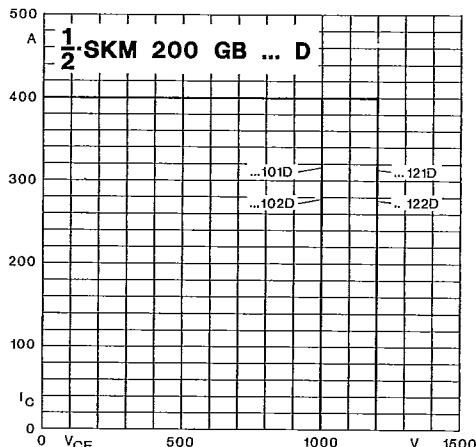
SEMIKRON

Fig. 26 Turn-off safe operating area

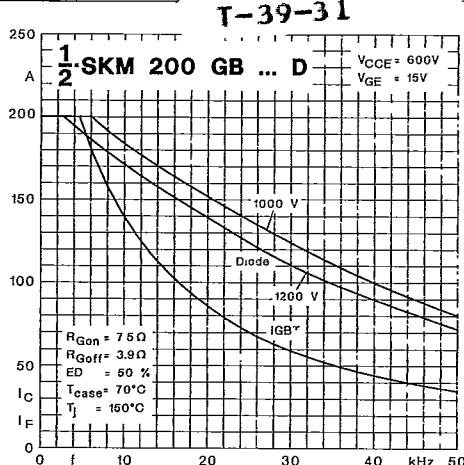


Fig. 27 Rated current vs. pulse frequency

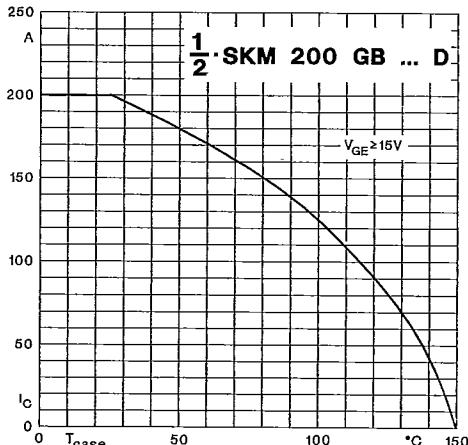


Fig. 28 Rated current vs. temperature

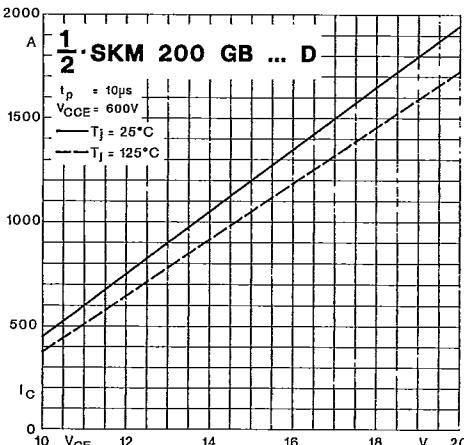


Fig. 29 Short-circuit current vs. turn-on gate voltage

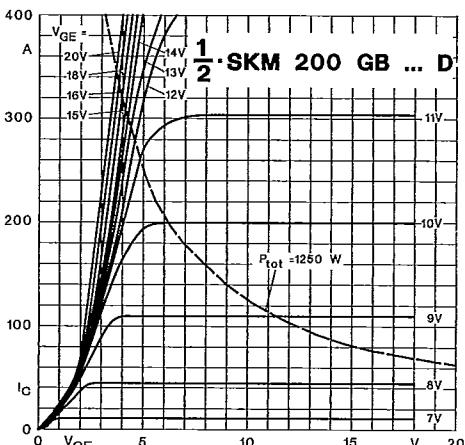


Fig. 30 Output characteristic

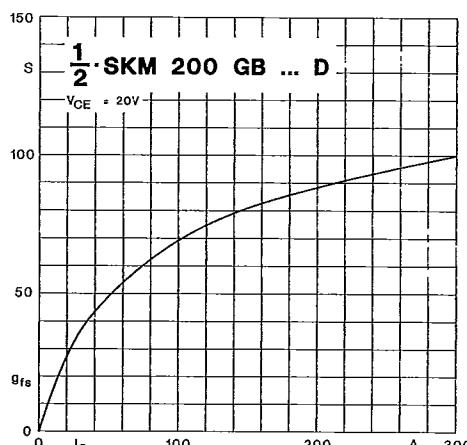
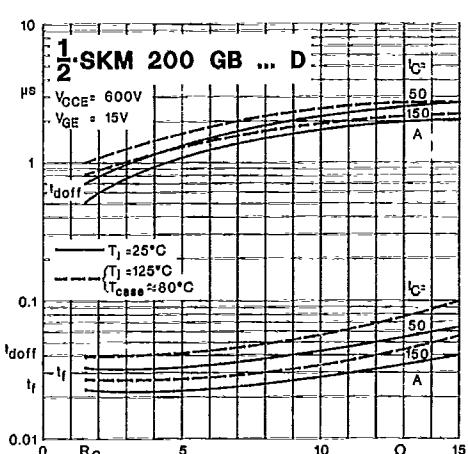
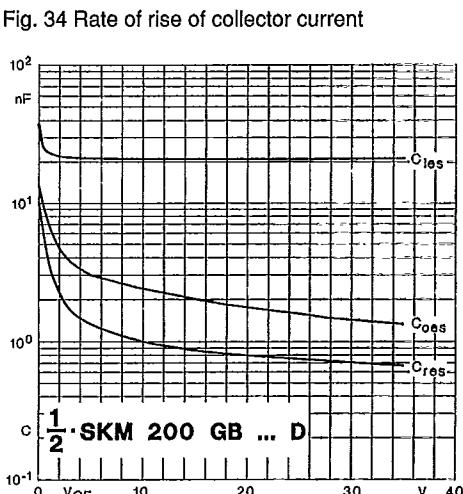
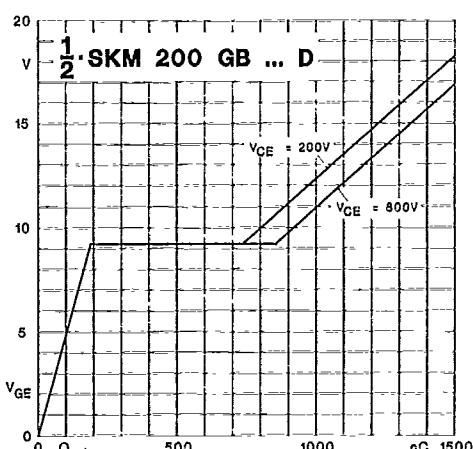
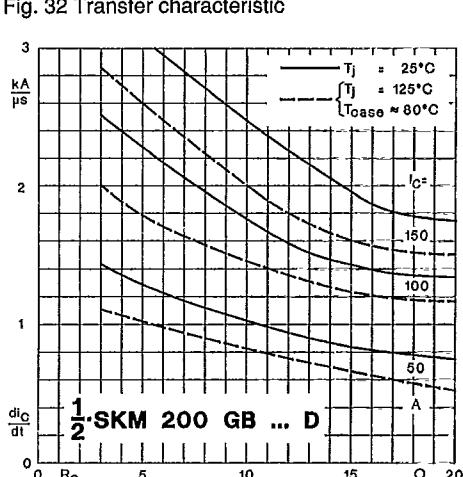
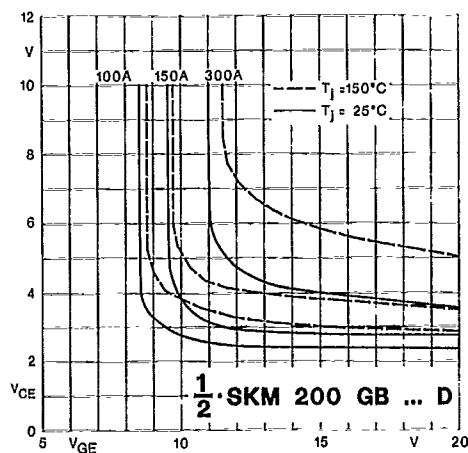
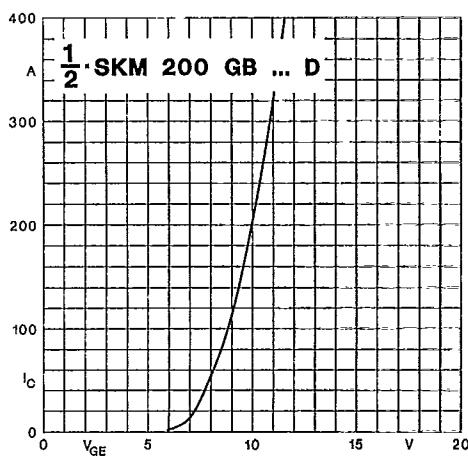


Fig. 31 Forward transconductance



SEMIKRON INC

SEMIKRON

T-39-31

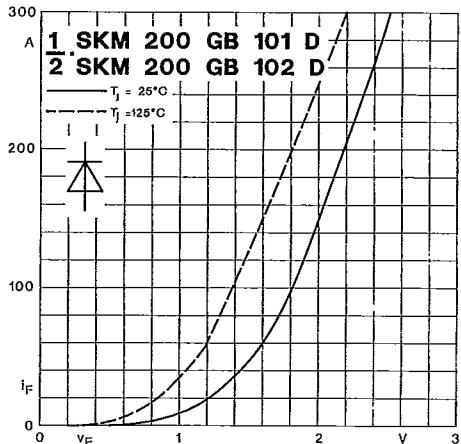


Fig. 38 a Diode forward characteristic

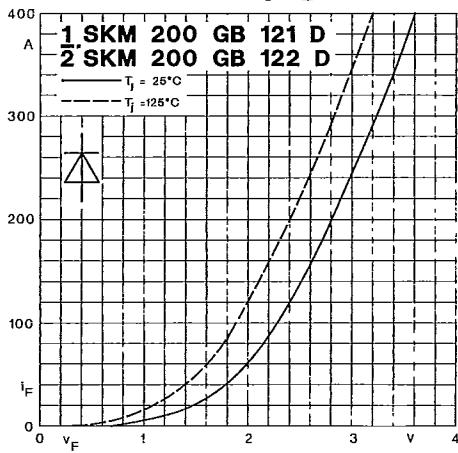


Fig. 38 b Diode forward characteristic

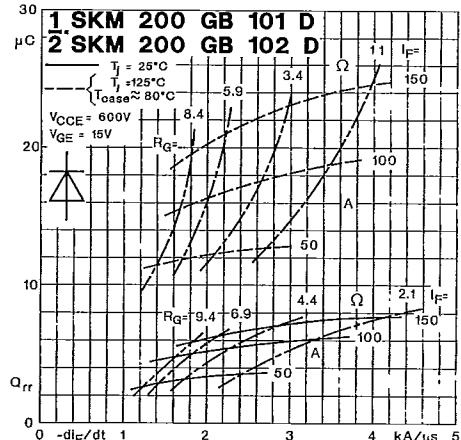


Fig. 39 a Diode recovered charge

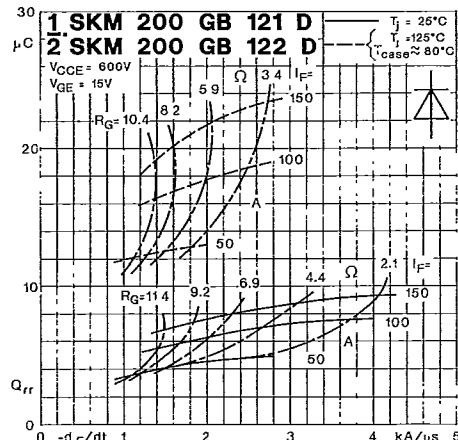
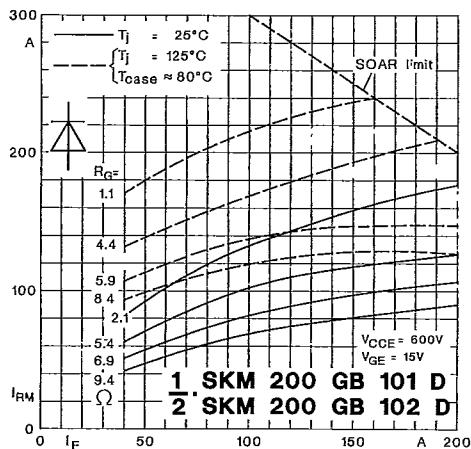
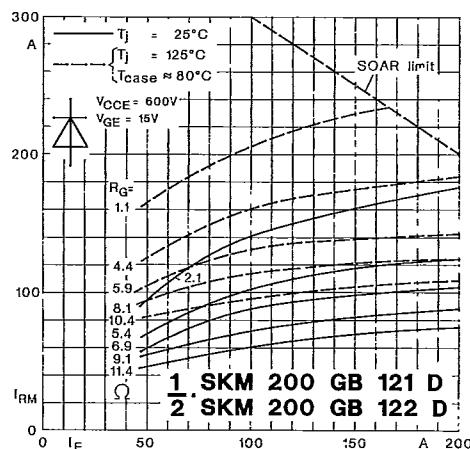


Fig. 39 b Diode recovered charge

Fig. 40 a Diode peak reverse recovery current (I_F)Fig. 40 b Diode peak reverse recovery current (I_F)

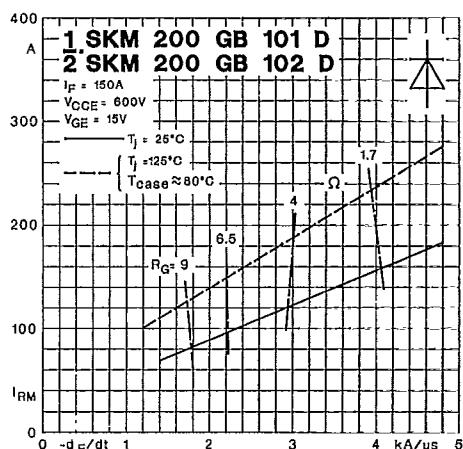
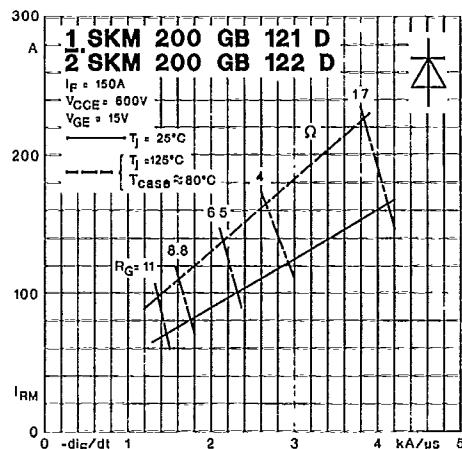
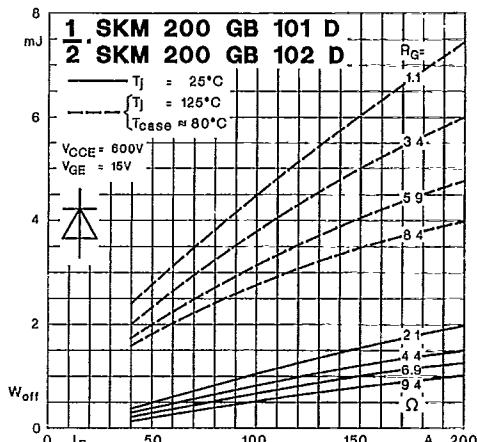
Fig. 41 a Diode peak reverse recovery current ($-dI_F/dt$)Fig. 41 b Diode peak reverse recovery current ($-dI_F/dt$)

Fig. 42 a Diode turn-off energy dissipation per pulse

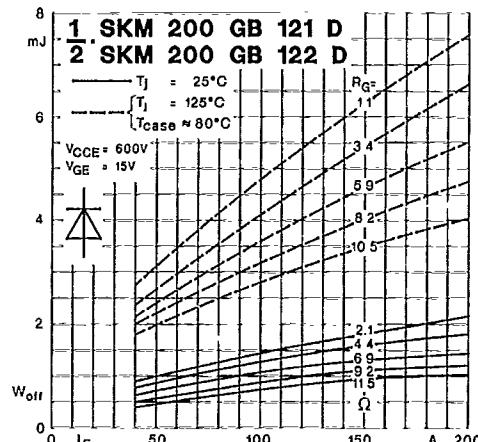
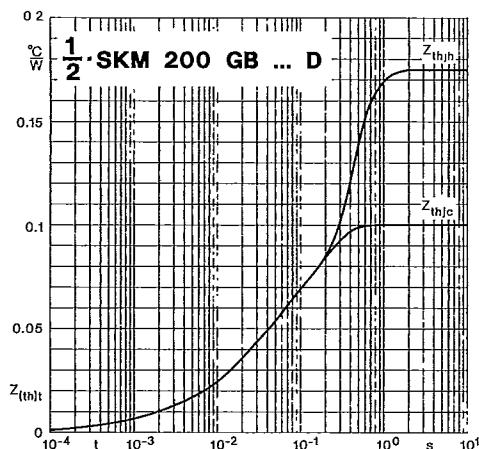


Fig. 42 b Diode turn-off energy dissipation per pulse

SEMIKRON INC

SEMIKRON

T-39-31

Fig. 51 Transient thermal impedance

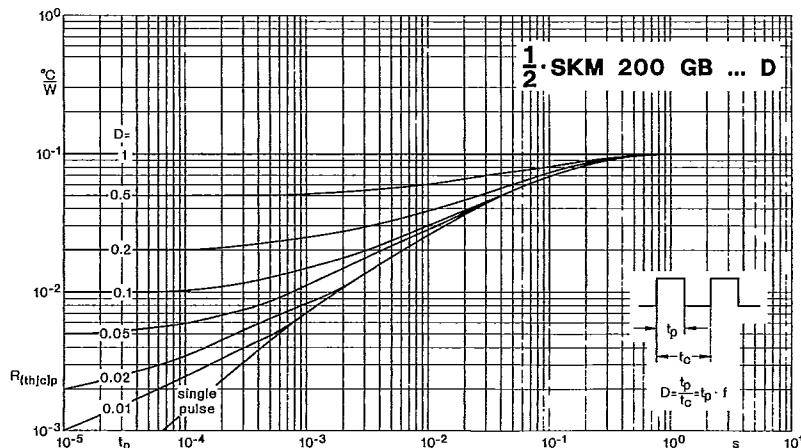
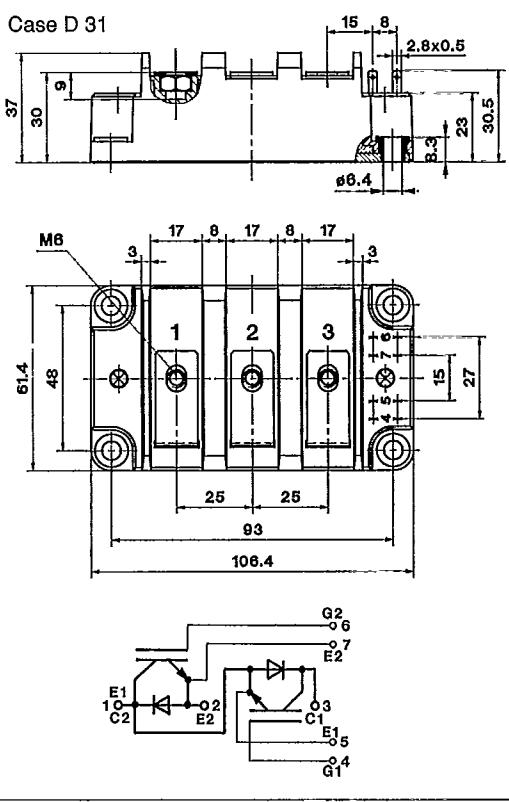


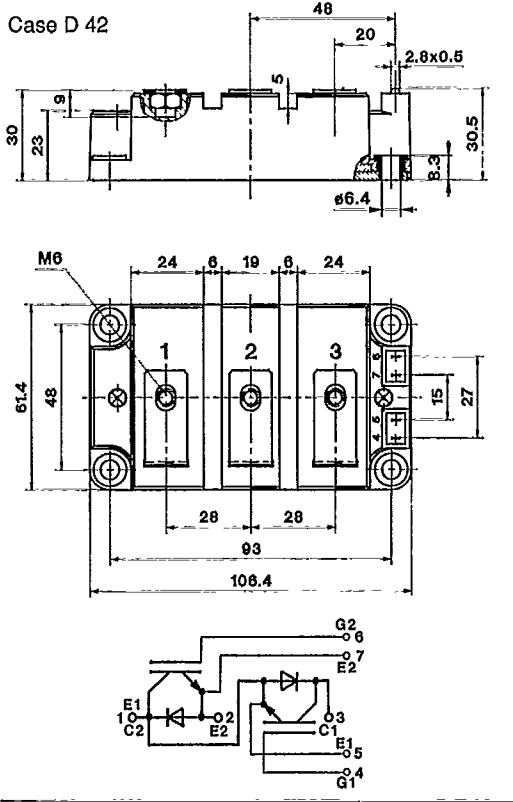
Fig. 52 Thermal impedance under pulse conditions

SKM 200 GB 101 D**SKM 200 GB 121 D**

Case D 31

UL recognized,
file no. E 63 532**SKM 200 GB 102 D****SKM 200 GB 122 D**

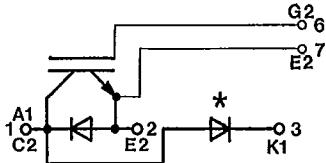
Case D 42

UL recognized,
file no. E 63 532**SKM 200 GAL 101 D****SKM 200 GAL 121 D**

Case D 35 (→ D 31)

SKM 200 GAL 102 D**SKM 200 GAL 122 D**

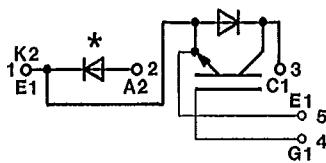
Case D 43 (→ D 42)

**SKM 200 GAR 101 D****SKM 200 GAR 121 D**

Case D 36 (→ D 31)

SKM 200 GAR 122 D

Case D 44 (→ D 42)

**Mechanical Data****Symbol****Conditions**Values
mln.
typ.

max.

Units

M ₁	to heatsink, SI Units	3	—	6	Nm
	to heatsink, US Units	27	—	53	lb.in.
M ₂	for terminals, SI Units	2,5	—	5	Nm
	for terminals US Units	22	—	44	lb.in.
a		—	—	5x9,81	m/s ²
w		—	—	420	g

This is an electrostatic discharge sensitive device (ESDS). Please observe the international standard IEC 747-1, Chapter IX.

*The free-wheeling diode has the data of the inverse diode of SKM 300 ...

Dimensions in mm